

AONS66607

60V N-Channel MOSFET

General Description

- Trench Power AlphaSGTTM technology
- Low R_{DS(ON)}
- Logic Level Driving
- Excellent Q_G x R_{DS(ON)} Product (FOM)
- RoHS 2.0 and Halogen-Free Compliant

Applications

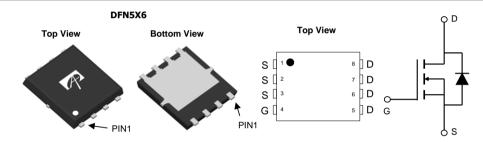
- · Buck-boost Converters in Computing
- Point of Load Converter

Product Summary

 $\begin{array}{ll} V_{DS} & 60V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 75A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 6m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 8m\Omega \end{array}$

100% UIS Tested 100% Rg Tested





Orderable Part Number Package Type		Form	Minimum Order Quantity	
AONS66607	DFN 5x6	Tape & Reel	3000	

Absolute Maximum Ratings T_A=25°C unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage	Э	V_{GS}	±20	V	
Continuous Drain	T _C =25°C		75		
Current	T _C =100°C	I _D	48	А	
Pulsed Drain Current ^C		I _{DM}	300	\neg	
Continuous Drain T _A =25°C			24	А	
Current	T _A =70°C	IDSM	19	^	
Avalanche Current ^C		I _{AS}	28	А	
Avalanche energy	L=0.1mH	E _{AS}	39	mJ	
	T _C =25°C	P _D	63	W	
Power Dissipation ^B	T _C =100°C	- D	25	7 vv	
	T _A =25°C	P _{DSM}	6.2	W	
Power Dissipation ^A	T _A =70°C	- DSM	4	v	
Junction and Storage	e Temperature Range	T _J , T _{STG}	-55 to 150	°C	

Thermal Characteristics						
Parameter		Symbol	Тур	Max	Units	
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta,JA}$	15	20	°C/W	
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{\theta JA}$	40	50	°C/W	
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.6	2	°C/W	



Electrical Characteristics (T_{.I}=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units
STATIC F	PARAMETERS					
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V			1	
DSS	Zero Gate Voltage Drain Current	T _J =55	°C		5	μA
I _{GSS}	Gate-Body leakage current	$V_{DS}=0V$, $V_{GS}=\pm20V$			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.2	1.8	2.4	V
		V _{GS} =10V, I _D =20A		5	6	mΩ
R _{DS(ON)} Static Drain-Source On-Resistance	T _J =125	°C	8.2	10	11152	
		V_{GS} =4.5V, I_D =20A		6.4	8	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =20A		90		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V		0.7	1	V
Is	Maximum Body-Diode Continuous Current				70	Α
DYNAMIC	PARAMETERS					
C _{iss}	Input Capacitance			1525		pF
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =30V, f=1MHz		320		рF
C _{rss}	Reverse Transfer Capacitance			10		рF
R_g	Gate resistance	f=1MHz	0.6	1.3	2	Ω
SWITCHI	NG PARAMETERS					
Q _g (10V)	Total Gate Charge			24	34	nC
Q _g (4.5V)	Total Gate Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A		11	16	nC
Q_{gs}	Gate Source Charge	V _{GS} =10V, V _{DS} =30V, I _D =20A		4.6		nC
Q_{gd}	Gate Drain Charge			4		nC
Q _{oss}	Output Charge	V _{GS} =0V, V _{DS} =30V		22		nC
t _{D(on)}	Turn-On DelayTime			6.8		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =30V, R_L =1.5 Ω ,		2.6		ns
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		22		ns
t _f	Turn-Off Fall Time			3.8		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs		16.5		ns
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =20A, di/dt=500A/μs		45		nC

A. The value of $R_{\theta,JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on $R_{\theta,JA}$ t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\!\!=\!\!150^\circ\,$ C.

D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.

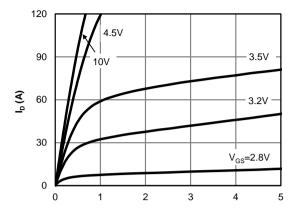
E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.

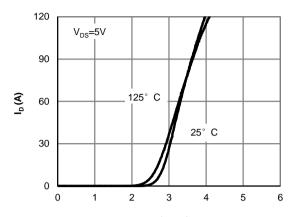
G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



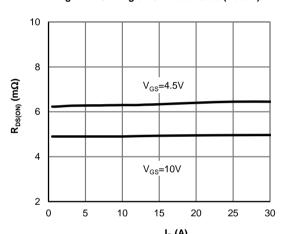
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



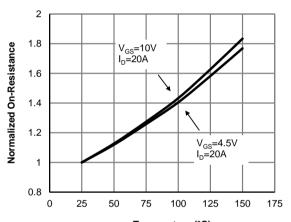
 $V_{\rm DS}$ (Volts) Figure 1: On-Region Characteristics (Note E)



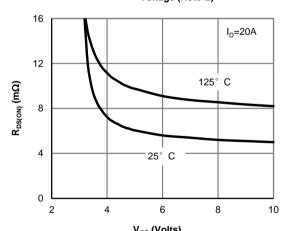
V_{GS} (Volts) Figure 2: Transfer Characteristics (Note E)



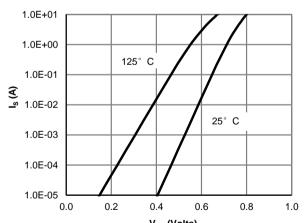
I_D (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)



Temperature (°C)
Figure 4: On-Resistance vs. Junction Temperature
(Note E)



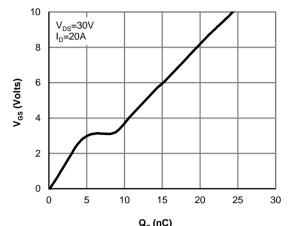
V_{GS} (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



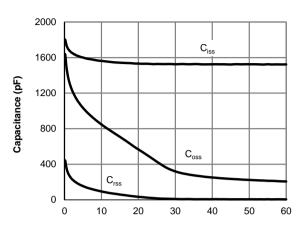
V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 Q_g (nC) Figure 7: Gate-Charge Characteristics



V_{DS} (Volts)
Figure 8: Capacitance Characteristics

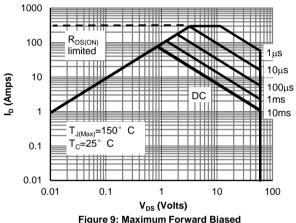
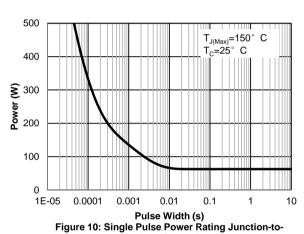
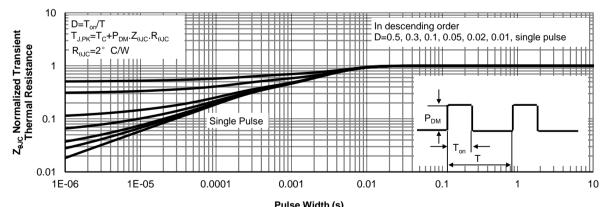


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)



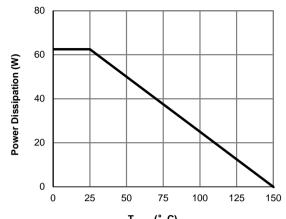
Case (Note F)



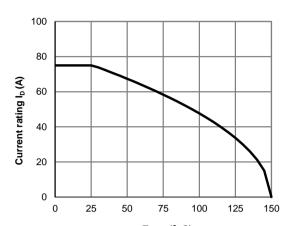
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



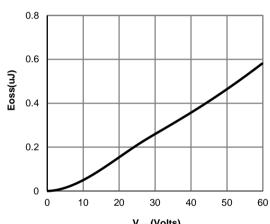
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



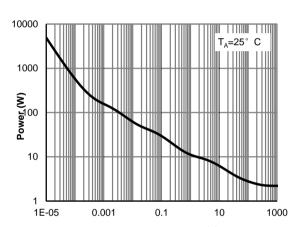
T_{CASE} (° C)
Figure 12: Power De-rating (Note F)



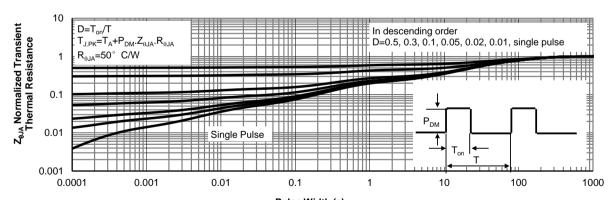
T_{CASE} (° C)
Figure 13: Current De-rating (Note F)



V_{DS} (Volts) Figure 14: Coss stored Energy



Pulse Width (s)
Figure 15: Single Pulse Power Rating Junctionto-Ambient (Note G)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

Figure A: Gate Charge Test Circuit & Waveforms

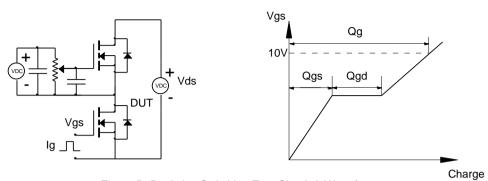


Figure B: Resistive Switching Test Circuit & Waveforms

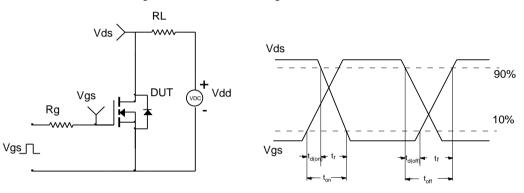


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

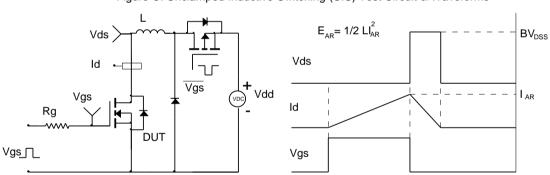


Figure D: Diode Recovery Test Circuit & Waveforms

